

Welcome to [E-XFL.COM](#)

### Understanding **Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Active
Number of LABs/CLBs	1825
Number of Logic Elements/Cells	23360
Total RAM Bits	1658880
Number of I/O	112
Number of Gates	-
Voltage - Supply	0.95V ~ 1.05V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	238-LFBGA, CSPBGA
Supplier Device Package	238-CSBGA (10x10)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7a25t-2cpg238c">https://www.e-xfl.com/product-detail/xilinx/xc7a25t-2cpg238c</a>

**Table 1: Absolute Maximum Ratings<sup>(1)</sup> (Cont'd)**

Symbol	Description	Min	Max	Units
<b>Temperature</b>				
T <sub>STG</sub>	Storage temperature (ambient)	-65	150	°C
T <sub>SOL</sub>	Maximum soldering temperature for Pb/Sn component bodies <sup>(6)</sup>	-	+220	°C
	Maximum soldering temperature for Pb-free component bodies <sup>(6)</sup>	-	+260	°C
T <sub>j</sub>	Maximum junction temperature <sup>(6)</sup>	-	+125	°C

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- The lower absolute voltage specification always applies.
- For I/O operation, refer to [UG471: 7 Series FPGAs SelectIO Resources User Guide](#).
- The maximum limit applied to DC signals.
- For maximum undershoot and overshoot AC specifications, see [Table 4](#).
- For soldering guidelines and thermal considerations, see [UG475: 7 Series FPGA Packaging and Pinout Specification](#).

**Table 2: Recommended Operating Conditions<sup>(1)(2)</sup>**

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
V <sub>CCINT</sub>	Internal supply voltage	0.95	1.00	1.05	V
	For -2L (0.9V) devices: internal supply voltage	0.87	0.90	0.93	V
V <sub>CCAUX</sub>	Auxiliary supply voltage	1.71	1.80	1.89	V
V <sub>CCBRAM</sub>	Block RAM supply voltage	0.95	1.00	1.05	V
V <sub>CCO</sub> <sup>(3)(4)</sup>	Supply voltage for 3.3V HR I/O banks	1.14	-	3.465	V
V <sub>IN</sub> <sup>(5)</sup>	I/O input voltage	-0.20	-	V <sub>CCO</sub> + 0.20	V
	I/O input voltage for V <sub>REF</sub> and differential I/O standards	-0.20	-	2.625	V
I <sub>IN</sub> <sup>(6)</sup>	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	-	-	10	mA
V <sub>CCBATT</sub> <sup>(7)</sup>	Battery voltage	1.0	-	1.89	V
<b>GTP Transceiver</b>					
V <sub>MGTAVCC</sub> <sup>(8)(9)</sup>	Analog supply voltage for the GTP transmitter and receiver circuits	0.97	1.0	1.03	V
V <sub>MGTAVTT</sub> <sup>(8)(9)</sup>	Analog supply voltage for the GTP transmitter and receiver termination circuits	1.17	1.2	1.23	V
<b>XADC</b>					
V <sub>CCADC</sub>	XADC supply relative to GNDADC	1.71	1.80	1.89	V
V <sub>REFP</sub>	Externally supplied reference voltage	1.20	1.25	1.30	V

**Table 6** shows the minimum current, in addition to  $I_{CCQ}$ , that is required by Artix-7 devices for proper power-on and configuration. If the current minimums shown in **Table 5** and **Table 6** are met, the device powers on after all four supplies have passed through their power-on reset threshold voltages. The FPGA must not be configured until after  $V_{CCINT}$  is applied.

Once initialized and configured, use the Xilinx Power Estimator (XPE) tools to estimate current drain on these supplies.

**Table 6: Power-On Current for Artix-7 Devices<sup>(1)</sup>**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	$I_{CCBRAMMIN}$	Units
	Typ <sup>(2)</sup>	Typ <sup>(2)</sup>	Typ <sup>(2)</sup>	Typ <sup>(2)</sup>	
XC7A100T	$I_{CCINTQ} + 170$	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 60$	mA
XC7A200T	$I_{CCINTQ} + 340$	$I_{CCAUXQ} + 50$	$I_{CCOQ} + 40$ mA per bank	$I_{CCBRAMQ} + 80$	mA

**Notes:**

1. Use the Xilinx Power Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.
2. Typical values are specified at nominal voltage, 25°C.

**Table 7: Power Supply Ramp Time**

Symbol	Description	Conditions	Min	Max	Units
$T_{VCCINT}$	Ramp time from GND to 90% of $V_{CCINT}$		0.2	50	ms
$T_{VCCO}$	Ramp time from GND to 90% of $V_{CCO}$		0.2	50	ms
$T_{VCCAUX}$	Ramp time from GND to 90% of $V_{CCAUX}$		0.2	50	ms
$T_{VCCBRAM}$	Ramp time from GND to 90% of $V_{CCBRAM}$		0.2	50	ms
$T_{VCCO2VCCAUX}$	Allowed time per power cycle for $V_{CCO} - V_{CCAUX} > 2.625V$	$T_J = 100^{\circ}\text{C}^{(1)}$	—	500	ms
		$T_J = 85^{\circ}\text{C}^{(1)}$	—	800	
$T_{MGTAVCC}$	Ramp time from GND to 90% of $V_{MGTAVCC}$		0.2	50	ms
$T_{MGTAVTT}$	Ramp time from GND to 90% of $V_{MGTAVTT}$		0.2	50	ms

**Notes:**

1. Based on 240,000 power cycles with nominal  $V_{CCO}$  of 3.3V or 36,500 power cycles with worst case  $V_{CCO}$  of 3.465V.

## LVDS DC Specifications (LVDS\_25)

See [UG471: 7 Series FPGAs SelectIO Resources User Guide](#) for more information on the LVDS\_25 standard in the HR I/O banks.

**Table 11: LVDS\_25 DC Specifications**

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$V_{CCO}$	Supply Voltage		2.375	2.500	2.625	V
$V_{OH}$	Output High Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	–	–	1.675	V
$V_{OL}$	Output Low Voltage for Q and $\bar{Q}$	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	0.700	–	–	V
$V_{ODIFF}$	Differential Output Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	247	350	600	mV
$V_{OCM}$	Output Common-Mode Voltage	$R_T = 100 \Omega$ across Q and $\bar{Q}$ signals	1.000	1.250	1.425	V
$V_{IDIFF}$	Differential Input Voltage ( $Q - \bar{Q}$ ), Q = High ( $\bar{Q} - Q$ ), $\bar{Q}$ = High		100	350	600	mV
$V_{ICM}$	Input Common-Mode Voltage		0.300	1.200	1.425	V

## AC Switching Characteristics

All values represented in this data sheet are based on the speed specifications in v1.07 from the 14.4/2012.4 device pack for ISE® Design Suite14.4 and Vivado® Design Suite 2012.4 for the -3, -2, -2L (1.0V), and -1 speed grades and v1.05 from the 14.4/2012.4 device pack for the -2L (0.9V) speed grade.

Switching characteristics are specified on a per-speed-grade basis and can be designated as Advance, Preliminary, or Production. Each designation is defined as follows:

### **Advance Product Specification**

These specifications are based on simulations only and are typically available soon after device design specifications are frozen. Although speed grades with this designation are considered relatively stable and conservative, some under-reporting might still occur.

### **Preliminary Product Specification**

These specifications are based on complete ES (engineering sample) silicon characterization. Devices and speed grades with this designation are intended to give a better indication of the expected performance of production silicon. The probability of under-reporting delays is greatly reduced as compared to Advance data.

### **Production Product Specification**

These specifications are released once enough production silicon of a particular device family member has been characterized to provide full correlation between specifications and devices over numerous production lots. There is no under-reporting of delays, and customers receive formal notification of any subsequent changes. Typically, the slowest speed grades transition to Production before faster speed grades.

## Testing of AC Switching Characteristics

Internal timing parameters are derived from measuring internal test patterns. All AC switching characteristics are representative of worst-case supply voltage and junction temperature conditions.

For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer and back-annotate to the simulation net list. Unless otherwise noted, values apply to all Artix-7 FPGAs.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Artix-7 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 9](#).

**Table 14: Networking Applications Interface Performances**

Description	Speed Grade				Units	
	1.0V		0.9V			
	-3	-2/-2L	-1	-2L		
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	680	680	600	600	Mb/s	
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	1250	1250	950	950	Mb/s	
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	680	680	600	600	Mb/s	
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	1250	1250	950	950	Mb/s	

**Notes:**

- LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

**Table 15: Maximum Physical Interface (PHY) Rate for Memory Interfaces<sup>(1)(2)</sup>**

Memory Standard	Speed Grade				Units	
	1.0V		0.9V			
	-3	-2/-2L	-1	-2L		
<b>4:1 Memory Controllers</b>						
DDR3	1066	800	800	800	Mb/s	
DDR3L	800	800	667	667	Mb/s	
DDR2	800	800	667	667	Mb/s	
LPDDR2	667	667	533	533	Mb/s	
<b>2:1 Memory Controllers</b>						
DDR3	800	700	620	620	Mb/s	
DDR3L	800	700	620	620	Mb/s	
DDR2	800	700	620	620	Mb/s	

**Notes:**

- $V_{REF}$  tracking is required. For more information, see [UG586, 7 Series FPGAs Memory Interface Solutions User Guide](#).
- When using the internal  $V_{REF}$  the maximum data rate is 800 Mb/s (400 MHz).

Table 16: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units	
	Speed Grade				Speed Grade				Speed Grade					
	1.0V		0.9V		1.0V		0.9V		1.0V		0.9V			
	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L	-3	-2/-2L	-1	-2L		
LVCMOS15_F4	0.77	0.86	0.93	0.98	1.85	1.97	2.23	2.27	2.42	2.63	3.06	2.92	ns	
LVCMOS15_F8	0.77	0.86	0.93	0.98	1.60	1.72	1.98	2.21	2.17	2.38	2.81	2.86	ns	
LVCMOS15_F12	0.77	0.86	0.93	0.98	1.35	1.47	1.73	1.96	1.92	2.13	2.56	2.61	ns	
LVCMOS15_F16	0.77	0.86	0.93	0.98	1.34	1.46	1.71	1.94	1.90	2.12	2.54	2.59	ns	
LVCMOS12_S4	0.87	0.95	1.02	1.08	2.57	2.69	2.95	3.18	3.14	3.35	3.78	3.83	ns	
LVCMOS12_S8	0.87	0.95	1.02	1.08	2.09	2.21	2.46	2.69	2.65	2.87	3.29	3.34	ns	
LVCMOS12_S12	0.87	0.95	1.02	1.08	1.79	1.91	2.17	2.40	2.36	2.57	2.99	3.05	ns	
LVCMOS12_F4	0.87	0.95	1.02	1.08	1.98	2.10	2.35	2.58	2.54	2.76	3.18	3.23	ns	
LVCMOS12_F8	0.87	0.95	1.02	1.08	1.54	1.66	1.92	2.15	2.11	2.32	2.75	2.80	ns	
LVCMOS12_F12	0.87	0.95	1.02	1.08	1.38	1.51	1.76	1.97	1.95	2.16	2.59	2.62	ns	
SSTL135_S	0.67	0.75	0.82	0.87	1.35	1.47	1.73	1.93	1.92	2.13	2.56	2.58	ns	
SSTL15_S	0.60	0.68	0.75	0.80	1.30	1.43	1.68	1.88	1.87	2.09	2.51	2.53	ns	
SSTL18_I_S	0.67	0.75	0.82	0.87	1.67	1.79	2.04	2.24	2.23	2.45	2.87	2.89	ns	
SSTL18_II_S	0.67	0.75	0.82	0.87	1.31	1.43	1.68	1.91	1.87	2.09	2.51	2.56	ns	
DIFF_SSTL135_S	0.68	0.76	0.83	0.87	1.35	1.47	1.73	1.93	1.92	2.13	2.56	2.58	ns	
DIFF_SSTL15_S	0.68	0.76	0.83	0.87	1.30	1.43	1.68	1.88	1.87	2.09	2.51	2.53	ns	
DIFF_SSTL18_I_S	0.71	0.79	0.86	0.87	1.68	1.80	2.06	2.24	2.25	2.46	2.89	2.89	ns	
DIFF_SSTL18_II_S	0.71	0.79	0.86	0.87	1.38	1.51	1.76	1.94	1.95	2.17	2.59	2.59	ns	
SSTL135_F	0.67	0.75	0.82	0.87	1.12	1.24	1.49	1.71	1.69	1.90	2.32	2.36	ns	
SSTL15_F	0.60	0.68	0.75	0.80	1.07	1.19	1.45	1.68	1.64	1.85	2.28	2.33	ns	
SSTL18_I_F	0.67	0.75	0.82	0.87	1.12	1.24	1.49	1.72	1.69	1.90	2.32	2.37	ns	
SSTL18_II_F	0.67	0.75	0.82	0.87	1.12	1.24	1.49	1.71	1.69	1.90	2.32	2.36	ns	
DIFF_SSTL135_F	0.68	0.76	0.83	0.87	1.12	1.24	1.49	1.71	1.69	1.90	2.32	2.36	ns	
DIFF_SSTL15_F	0.68	0.76	0.83	0.87	1.07	1.19	1.45	1.68	1.64	1.85	2.28	2.33	ns	
DIFF_SSTL18_I_F	0.71	0.79	0.86	0.87	1.23	1.35	1.60	1.80	1.79	2.01	2.43	2.45	ns	
DIFF_SSTL18_II_F	0.71	0.79	0.86	0.87	1.21	1.33	1.59	1.79	1.78	1.99	2.42	2.44	ns	

Table 17 specifies the values of T<sub>IOTPHZ</sub> and T<sub>IOIBUFDISABLE</sub>. T<sub>IOTPHZ</sub> is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state). T<sub>IOIBUFDISABLE</sub> is described as the IOB delay from IBUFDISABLE to O output. In HR I/O banks, the internal IN\_TERM termination turn-off time is always faster than T<sub>IOTPHZ</sub> when the INTERMDISABLE pin is used.

Table 17: IOB 3-state Output Switching Characteristics

Symbol	Description	Speed Grade				Units	
		1.0V		0.9V			
		-3	-2/-2L	-1	-2L		
T <sub>IOTPHZ</sub>	T input to pad high-impedance	2.06	2.19	2.37	2.19	ns	
T <sub>IOIBUFDISABLE</sub>	IBUF turn-on time from IBUFDISABLE to O output	2.11	2.30	2.60	2.30	ns	

## Input Serializer/Deserializer Switching Characteristics

Table 20: ISERDES Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup/Hold for Control Lines</b>						
T <sub>ISCKC_BITSILIP</sub> /T <sub>ISCKKC_BITSILIP</sub>	BITSLIP pin setup/hold with respect to CLKDIV	0.01/0.14	0.02/0.15	0.02/0.17	0.02/0.21	ns
T <sub>ISCKC_CE</sub> / T <sub>ISCKKC_CE</sub> <sup>(2)</sup>	CE pin setup/hold with respect to CLK (for CE1)	0.45/-0.01	0.50/-0.01	0.72/-0.01	0.35/-0.11	ns
T <sub>ISCKC_CE2</sub> / T <sub>ISCKKC_CE2</sub> <sup>(2)</sup>	CE pin setup/hold with respect to CLKDIV (for CE2)	-0.10/0.33	-0.10/0.36	-0.10/0.40	-0.17/0.40	ns
<b>Setup/Hold for Data Lines</b>						
T <sub>ISDCK_D</sub> /T <sub>ISCKD_D</sub>	D pin setup/hold with respect to CLK	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.04/0.19	ns
T <sub>ISDCK_DDLY</sub> /T <sub>ISCKD_DDLY</sub>	DDLY pin setup/hold with respect to CLK (using IDELAY) <sup>(1)</sup>	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.03/0.19	ns
T <sub>ISDCK_D_DDR</sub> /T <sub>ISCKD_D_DDR</sub>	D pin setup/hold with respect to CLK at DDR mode	-0.02/0.12	-0.02/0.14	-0.02/0.17	-0.04/0.19	ns
T <sub>ISDCK_DDLY_DDR</sub> /T <sub>ISCKD_DDLY_DDR</sub>	D pin setup/hold with respect to CLK at DDR mode (using IDELAY) <sup>(1)</sup>	0.12/0.12	0.14/0.14	0.17/0.17	0.19/0.19	ns
<b>Sequential Delays</b>						
T <sub>ISCKO_Q</sub>	CLKDIV to out at Q pin	0.53	0.54	0.66	0.67	ns
<b>Propagation Delays</b>						
T <sub>ISDO_DO</sub>	D input to DO output pin	0.11	0.11	0.13	0.14	ns

**Notes:**

1. Recorded at 0 tap value.
2. T<sub>ISCKC\_CE2</sub> and T<sub>ISCKKC\_CE2</sub> are reported as T<sub>ISCKC\_CE</sub>/T<sub>ISCKKC\_CE</sub> in TRACE report.

Table 23: IO\_FIFO Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>IO_FIFO Clock to Out Delays</b>						
T <sub>OFFCKO_DO</sub>	RDCLK to Q outputs	0.55	0.60	0.68	0.81	ns
T <sub>CKO_FLAGS</sub>	Clock to IO_FIFO flags	0.55	0.61	0.77	0.55	ns
<b>Setup/Hold</b>						
T <sub>CCK_D/T<sub>CKC_D</sub></sub>	D inputs to WRCLK	0.47/0.02	0.51/0.02	0.58/0.02	0.76/-0.05	ns
T <sub>IFFCCK_WREN/T<sub>IFFCKC_WREN</sub></sub>	WREN to WRCLK	0.42/-0.01	0.47/-0.01	0.53/-0.01	0.70/-0.05	ns
T <sub>OFFCCK_RDEN/T<sub>OFFCKC_RDEN</sub></sub>	RDEN to RDCLK	0.53/0.02	0.58/0.02	0.66/0.02	0.79/-0.02	ns
<b>Minimum Pulse Width</b>						
T <sub>PWH_IO_FIFO</sub>	RESET, RDCLK, WRCLK	1.62	2.15	2.15	2.15	ns
T <sub>PWL_IO_FIFO</sub>	RESET, RDCLK, WRCLK	1.62	2.15	2.15	2.15	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	RDCLK and WRCLK	266.67	200.00	200.00	200.00	MHz

Table 27: Block RAM and FIFO Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T <sub>RCKC_RSTRAM</sub> /T <sub>RCKC_RSTRAM</sub>	Synchronous RSTRAM input	0.32/0.42	0.34/0.43	0.36/0.46	0.40/0.47	ns, Min
T <sub>RCKC_WEA</sub> /T <sub>RCKC_WEA</sub>	Write enable (WE) input (block RAM only)	0.44/0.18	0.48/0.19	0.54/0.20	0.64/0.23	ns, Min
T <sub>RCKC_WREN</sub> /T <sub>RCKC_WREN</sub>	WREN FIFO inputs	0.46/0.30	0.46/0.35	0.47/0.43	0.77/0.44	ns, Min
T <sub>RCKC_RDEN</sub> /T <sub>RCKC_RDEN</sub>	RDEN FIFO inputs	0.42/0.30	0.43/0.35	0.43/0.43	0.71/0.44	ns, Min
<b>Reset Delays</b>						
T <sub>RCO_FLAGS</sub>	Reset RST to FIFO flags/pointers <sup>(10)</sup>	0.90	0.98	1.10	1.25	ns, Max
T <sub>RREC_RST</sub> /T <sub>RREM_RST</sub>	FIFO reset recovery and removal timing <sup>(11)</sup>	1.87/-0.81	2.07/-0.81	2.37/-0.81	2.44/-0.71	ns, Max
<b>Maximum Frequency</b>						
F <sub>MAX_BRAM_WF_NC</sub>	Block RAM (write first and no change modes) when not in SDP RF mode	509.68	460.83	388.20	315.66	MHz
F <sub>MAX_BRAM_RF_PERFORMANCE</sub>	Block RAM (read first, performance mode) when in SDP RF mode but no address overlap between port A and port B	509.68	460.83	388.20	315.66	MHz
F <sub>MAX_BRAM_RF_DELAYED_WRITE</sub>	Block RAM (read first, delayed write mode) when in SDP RF mode and there is possibility of overlap between port A and port B addresses	447.63	404.53	339.67	268.96	MHz
F <sub>MAX_CAS_WF_NC</sub>	Block RAM cascade (write first, no change mode) when cascade but not in RF mode	467.07	418.59	345.78	273.30	MHz
F <sub>MAX_CAS_RF_PERFORMANCE</sub>	Block RAM cascade (read first, performance mode) when in cascade with RF mode and no possibility of address overlap/one port is disabled	467.07	418.59	345.78	273.30	MHz
F <sub>MAX_CAS_RF_DELAYED_WRITE</sub>	When in cascade RF mode and there is a possibility of address overlap between port A and port B	405.35	362.19	297.35	226.60	MHz
F <sub>MAX_FIFO</sub>	FIFO in all modes without ECC	509.68	460.83	388.20	315.66	MHz
F <sub>MAX_ECC</sub>	Block RAM and FIFO in ECC configuration	410.34	365.10	297.53	215.38	MHz

**Notes:**

1. TRACE will report all of these parameters as T<sub>RCKO\_DO</sub>.
2. T<sub>RCKO\_DOR</sub> includes T<sub>RCKO\_DOW</sub>, T<sub>RCKO\_DOPR</sub>, and T<sub>RCKO\_DOPW</sub> as well as the B port equivalent timing parameters.
3. These parameters also apply to synchronous FIFO with DO\_REG = 0.
4. T<sub>RCKO\_DO</sub> includes T<sub>RCKO\_DOP</sub> as well as the B port equivalent timing parameters.
5. These parameters also apply to multirate (asynchronous) and synchronous FIFO with DO\_REG = 1.
6. T<sub>RCKO\_FLAGS</sub> includes the following parameters: T<sub>RCKO\_AEMPTY</sub>, T<sub>RCKO\_AFULL</sub>, T<sub>RCKO\_EMPTY</sub>, T<sub>RCKO\_FULL</sub>, T<sub>RCKO\_RDERR</sub>, T<sub>RCKO\_WRERR</sub>.
7. T<sub>RCKO\_POINTERS</sub> includes both T<sub>RCKO\_RDCOUNT</sub> and T<sub>RCKO\_WRCOUNT</sub>.
8. The ADDR setup and hold must be met when EN is asserted (even when WE is deasserted). Otherwise, block RAM data corruption is possible.
9. These parameters include both A and B inputs as well as the parity inputs of A and B.
10. T<sub>RCO\_FLAGS</sub> includes the following flags: AEMPTY, AFULL, EMPTY, FULL, RDERR, WRERR, RDCOUNT, and WRCOUNT.
11. RDEN and WREN must be held Low prior to and during reset. The FIFO reset must be asserted for at least five positive clock edges of the slowest clock (WRCLK or RDCLK).

## DSP48E1 Switching Characteristics

Table 28: DSP48E1 Switching Characteristics

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup and Hold Times of Data/Control Pins to the Input Register Clock</b>						
T <sub>DSPDCK_A_AREG</sub> /T <sub>DSPCKD_A_AREG</sub>	A input to A register CLK	0.26/ 0.12	0.30/ 0.13	0.37/ 0.14	0.45/ 0.14	ns
T <sub>DSPDCK_B_BREG</sub> /T <sub>DSPCKD_B_BREG</sub>	B input to B register CLK	0.33/ 0.15	0.38/ 0.16	0.45/ 0.18	0.60/ 0.19	ns
T <sub>DSPDCK_C_CREG</sub> /T <sub>DSPCKD_C_CREG</sub>	C input to C register CLK	0.17/ 0.17	0.20/ 0.19	0.24/ 0.21	0.34/ 0.29	ns
T <sub>DSPDCK_D_DREG</sub> /T <sub>DSPCKD_D_DREG</sub>	D input to D register CLK	0.25/ 0.25	0.32/ 0.27	0.42/ 0.27	0.54/ 0.23	ns
T <sub>DSPDCK_ACIN_AREG</sub> /T <sub>DSPCKD_ACIN_AREG</sub>	ACIN input to A register CLK	0.23/ 0.12	0.27/ 0.13	0.32/ 0.14	0.36/ 0.14	ns
T <sub>DSPDCK_BCIN_BREG</sub> /T <sub>DSPCKD_BCIN_BREG</sub>	BCIN input to B register CLK	0.25/ 0.15	0.29/ 0.16	0.36/ 0.18	0.41/ 0.19	ns
<b>Setup and Hold Times of Data Pins to the Pipeline Register Clock</b>						
T <sub>DSPDCK_{A,B}_MREG_MULT</sub> / T <sub>DSPCKD_B_MREG_MULT</sub>	{A, B} input to M register CLK using multiplier	2.40/ -0.01	2.76/ -0.01	3.29/ -0.01	4.31/ -0.07	ns
T <sub>DSPDCK_{A,B}_ADREG</sub> /T <sub>DSPCKD_D_ADREG</sub>	{A, D} input to AD register CLK	1.29/ -0.02	1.48/ -0.02	1.76/ -0.02	2.29/ -0.27	ns
<b>Setup and Hold Times of Data/Control Pins to the Output Register Clock</b>						
T <sub>DSPDCK_{A,B}_PREG_MULT</sub> / T <sub>DSPCKD_{A,B}_PREG_MULT</sub>	{A, B} input to P register CLK using multiplier	4.02/ -0.28	4.60/ -0.28	5.48/ -0.28	6.95/ -0.48	ns
T <sub>DSPDCK_D_PREG_MULT</sub> / T <sub>DSPCKD_D_PREG_MULT</sub>	D input to P register CLK using multiplier	3.93/ -0.73	4.50/ -0.73	5.35/ -0.73	6.73/ -1.68	ns
T <sub>DSPDCK_{A,B}_PREG</sub> / T <sub>DSPCKD_{A,B}_PREG</sub>	A or B input to P register CLK not using multiplier	1.73/ -0.28	1.98/ -0.28	2.35/ -0.28	2.80/ -0.48	ns
T <sub>DSPDCK_C_PREG</sub> / T <sub>DSPCKD_C_PREG</sub>	C input to P register CLK not using multiplier	1.54/ -0.26	1.76/ -0.26	2.10/ -0.26	2.54/ -0.45	ns
T <sub>DSPDCK_PCIN_PREG</sub> / T <sub>DSPCKD_PCIN_PREG</sub>	PCIN input to P register CLK	1.32/ -0.15	1.51/ -0.15	1.80/ -0.15	2.13/ -0.25	ns
<b>Setup and Hold Times of the CE Pins</b>						
T <sub>DSPDCK_{CEA;CEB}_{AREG;BREG}</sub> / T <sub>DSPCKD_{CEA;CEB}_{AREG;BREG}</sub>	{CEA; CEB} input to {A; B} register CLK	0.35/ 0.06	0.42/ 0.08	0.52/ 0.11	0.64/ 0.11	ns
T <sub>DSPDCK_CEC_CREG</sub> /T <sub>DSPCKD_CEC_CREG</sub>	CEC input to C register CLK	0.28/ 0.10	0.34/ 0.11	0.42/ 0.13	0.49/ 0.16	ns
T <sub>DSPDCK_CED_DREG</sub> /T <sub>DSPCKD_CED_DREG</sub>	CED input to D register CLK	0.36/ -0.03	0.43/ -0.03	0.52/ -0.03	0.68/ 0.14	ns
T <sub>DSPDCK_CEM_MREG</sub> /T <sub>DSPCKD_CEM_MREG</sub>	CEM input to M register CLK	0.17/ 0.18	0.21/ 0.20	0.27/ 0.23	0.45/ 0.29	ns
T <sub>DSPDCK_CEP_PREG</sub> /T <sub>DSPCKD_CEP_PREG</sub>	CEP input to P register CLK	0.36/ 0.01	0.43/ 0.01	0.53/ 0.01	0.63/ 0.00	ns

Table 28: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Setup and Hold Times of the RST Pins</b>						
$T_{DSPDCK\_RSTA; RSTB\_AREG; BREG}/T_{DSPCKD\_RSTA; RSTB\_AREG; BREG}$	{RSTA, RSTB} input to {A, B} register CLK	0.41/ 0.11	0.46/ 0.13	0.55/ 0.15	0.63/ 0.40	ns
$T_{DSPDCK\_RSTC\_CREG}/T_{DSPCKD\_RSTC\_CREG}$	RSTC input to C register CLK	0.07/ 0.10	0.08/ 0.11	0.09/ 0.12	0.13/ 0.11	ns
$T_{DSPDCK\_RSTD\_DREG}/T_{DSPCKD\_RSTD\_DREG}$	RSTD input to D register CLK	0.44/ 0.07	0.50/ 0.08	0.59/ 0.09	0.67/ 0.08	ns
$T_{DSPDCK\_RSTM\_MREG}/T_{DSPCKD\_RSTM\_MREG}$	RSTM input to M register CLK	0.21/ 0.22	0.23/ 0.24	0.27/ 0.28	0.28/ 0.35	ns
$T_{DSPDCK\_RSTP\_PREG}/T_{DSPCKD\_RSTP\_PREG}$	RSTP input to P register CLK	0.27/ 0.01	0.30/ 0.01	0.35/ 0.01	0.43/ 0.00	ns
<b>Combinatorial Delays from Input Pins to Output Pins</b>						
$T_{DSPDO\_A\_CARRYOUT\_MULT}$	A input to CARRYOUT output using multiplier	3.79	4.35	5.18	6.61	ns
$T_{DSPDO\_D\_P\_MULT}$	D input to P output using multiplier	3.72	4.26	5.07	6.41	ns
$T_{DSPDO\_B\_P}$	B input to P output not using multiplier	1.53	1.75	2.08	2.48	ns
$T_{DSPDO\_C\_P}$	C input to P output	1.33	1.53	1.82	2.22	ns
<b>Combinatorial Delays from Input Pins to Cascading Output Pins</b>						
$T_{DSPDO\_A; B}\_ACOUT; BCOUT}$	{A, B} input to {ACOUT, BCOUT} output	0.55	0.63	0.74	0.87	ns
$T_{DSPDO\_A, B}\_CARRYCASOUT\_MULT}$	{A, B} input to CARRYCASOUT output using multiplier	4.06	4.65	5.54	7.03	ns
$T_{DSPDO\_D}\_CARRYCASOUT\_MULT$	D input to CARRYCASOUT output using multiplier	3.97	4.54	5.40	6.81	ns
$T_{DSPDO\_A, B}\_CARRYCASOUT$	{A, B} input to CARRYCASOUT output not using multiplier	1.77	2.03	2.41	2.88	ns
$T_{DSPDO\_C}\_CARRYCASOUT$	C input to CARRYCASOUT output	1.58	1.81	2.15	2.62	ns
<b>Combinatorial Delays from Cascading Input Pins to All Output Pins</b>						
$T_{DSPDO\_ACIN\_P\_MULT}$	ACIN input to P output using multiplier	3.65	4.19	5.00	6.40	ns
$T_{DSPDO\_ACIN\_P}$	ACIN input to P output not using multiplier	1.37	1.57	1.88	2.44	ns
$T_{DSPDO\_ACIN\_ACOUT}$	ACIN input to ACOUT output	0.38	0.44	0.53	0.63	ns
$T_{DSPDO\_ACIN}\_CARRYCASOUT\_MULT$	ACIN input to CARRYCASOUT output using multiplier	3.90	4.47	5.33	6.79	ns
$T_{DSPDO\_ACIN}\_CARRYCASOUT$	ACIN input to CARRYCASOUT output not using multiplier	1.61	1.85	2.21	2.84	ns
$T_{DSPDO\_PCIN\_P}$	PCIN input to P output	1.11	1.28	1.52	1.82	ns
$T_{DSPDO\_PCIN}\_CARRYCASOUT$	PCIN input to CARRYCASOUT output	1.36	1.56	1.85	2.21	ns
<b>Clock to Outs from Output Register Clock to Output Pins</b>						
$T_{DSPCKO\_P\_PREG}$	CLK PREG to P output	0.33	0.37	0.44	0.54	ns
$T_{DSPCKO}\_CARRYCASOUT\_PREG$	CLK PREG to CARRYCASOUT output	0.52	0.59	0.69	0.84	ns

Table 28: DSP48E1 Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Clock to Outs from Pipeline Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_MREG</sub>	CLK MREG to P output	1.68	1.93	2.31	2.73	ns
T <sub>DSPCKO_CARRYCASCOU_MREG</sub>	CLK MREG to CARRYCASCOU output	1.92	2.21	2.64	3.12	ns
T <sub>DSPCKO_P_ADREG_MULT</sub>	CLK ADREG to P output using multiplier	2.72	3.10	3.69	4.60	ns
T <sub>DSPCKO_CARRYCASCOU_ADREG_MULT</sub>	CLK ADREG to CARRYCASCOU output using multiplier	2.96	3.38	4.02	4.99	ns
<b>Clock to Outs from Input Register Clock to Output Pins</b>						
T <sub>DSPCKO_P_AREG_MULT</sub>	CLK AREG to P output using multiplier	3.94	4.51	5.37	6.84	ns
T <sub>DSPCKO_P_BREG</sub>	CLK BREG to P output not using multiplier	1.64	1.87	2.22	2.65	ns
T <sub>DSPCKO_P_CREG</sub>	CLK CREG to P output not using multiplier	1.69	1.93	2.30	2.81	ns
T <sub>DSPCKO_P_DREG_MULT</sub>	CLK DREG to P output using multiplier	3.91	4.48	5.32	6.77	ns
<b>Clock to Outs from Input Register Clock to Cascading Output Pins</b>						
T <sub>DSPCKO_{ACOUT; BCOUT}_{AREG; BREG}</sub>	CLK (ACOUT, BCOUT) to {A,B} register output	0.64	0.73	0.87	1.02	ns
T <sub>DSPCKO_CARRYCASCOU_{AREG, BREG}_MULT</sub>	CLK (AREG, BREG) to CARRYCASCOU output using multiplier	4.19	4.79	5.70	7.24	ns
T <sub>DSPCKO_CARRYCASCOU_BREG</sub>	CLK BREG to CARRYCASCOU output not using multiplier	1.88	2.15	2.55	3.04	ns
T <sub>DSPCKO_CARRYCASCOU_DREG_MULT</sub>	CLK DREG to CARRYCASCOU output using multiplier	4.16	4.76	5.65	7.17	ns
T <sub>DSPCKO_CARRYCASCOU_CREG</sub>	CLK CREG to CARRYCASCOU output	1.94	2.21	2.63	3.20	ns
<b>Maximum Frequency</b>						
F <sub>MAX</sub>	With all registers used	628.93	550.66	464.25	363.77	MHz
F <sub>MAX_PATDET</sub>	With pattern detector	531.63	465.77	392.93	310.08	MHz
F <sub>MAX_MULT_NOMREG</sub>	Two register multiply without MREG	349.28	305.62	257.47	210.44	MHz
F <sub>MAX_MULT_NOMREG_PATDET</sub>	Two register multiply without MREG with pattern detect	317.26	277.62	233.92	191.28	MHz
F <sub>MAX_PREADD_MULT_NOADREG</sub>	Without ADREG	397.30	346.26	290.44	223.26	MHz
F <sub>MAX_PREADD_MULT_NOADREG_PATDET</sub>	Without ADREG with pattern detect	397.30	346.26	290.44	223.26	MHz
F <sub>MAX_NOPIPELINEREG</sub>	Without pipeline registers (MREG, ADREG)	260.01	227.01	190.69	150.13	MHz
F <sub>MAX_NOPIPELINEREG_PATDET</sub>	Without pipeline registers (MREG, ADREG) with pattern detect	241.72	211.15	177.43	140.10	MHz

## Clock Buffers and Networks

Table 29: Global Clock Switching Characteristics (Including BUFGCTRL)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BCCCK_CE/T_BCCKC_CE <sup>(1)</sup>	CE pins setup/hold	0.12/0.39	0.13/0.40	0.16/0.41	0.31/0.17	ns
T_BCCCK_S/T_BCCKC_S <sup>(1)</sup>	S pins setup/hold	0.12/0.39	0.13/0.40	0.16/0.41	0.31/0.17	ns
T_BGCKO_O <sup>(2)</sup>	BUFGCTRL delay from I0/I1 to O	0.08	0.09	0.10	0.14	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFG</sub>	Global clock tree (BUFG)	628.00	628.00	464.00	394.00	MHz

**Notes:**

1. T<sub>BCCCK\_CE</sub> and T<sub>BCCKC\_CE</sub> must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFGMUX primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.
2. T<sub>BGCKO\_O</sub> (BUFG delay from I0 to O) values are the same as T<sub>BCCKO\_O</sub> values.

Table 30: Input/Output Clock Switching Characteristics (BUFIO)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BLOCKO_O	Clock to out delay from I to O	1.11	1.26	1.54	1.56	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFIO</sub>	I/O clock tree (BUFIO)	680.00	680.00	600.00	600.00	MHz

Table 31: Regional Clock Buffer Switching Characteristics (BUFR)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BRCKO_O	Clock to out delay from I to O	0.64	0.76	0.99	1.24	ns
T_BRCKO_O_BYP	Clock to out delay from I to O with Divide Bypass attribute set	0.34	0.39	0.52	0.72	ns
T_BRDO_O	Propagation delay from CLR to O	0.81	0.85	1.09	0.96	ns
<b>Maximum Frequency</b>						
F <sub>MAX_BUFR</sub> <sup>(1)</sup>	Regional clock tree (BUFR)	420.00	375.00	315.00	315.00	MHz

**Notes:**

1. The maximum input frequency to the BUFR and BUFMR is the BUFIO F<sub>MAX</sub> frequency.

Table 32: Horizontal Clock Buffer Switching Characteristics (BUFH)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T_BHCKO_O	BUFH delay from I to O	0.10	0.11	0.13	0.16	ns
T_BHCKC_CE/T_BHCKC_CE	CE pin setup and hold	0.19/0.13	0.22/0.15	0.28/0.21	0.35/0.08	ns
<b>Maximum Frequency</b>						
F_MAX_BUHF	Horizontal clock buffer (BUFH)	628.00	628.00	464.00	394.00	MHz

Table 33: Duty Cycle Distortion and Clock-Tree Skew

Symbol	Description	Device	Speed Grade				Units
			1.0V		0.9V		
			-3	-2/-2L	-1	-2L	
T_DCD_CLK	Global clock tree duty-cycle distortion <sup>(1)</sup>	All	0.20	0.20	0.20	0.25	ns
T_CKSKEW	Global clock tree skew <sup>(2)</sup>	XC7A100T	0.27	0.33	0.36	0.48	ns
		XC7A200T	0.40	0.48	0.54	0.69	ns
T_DCD_BUFIO	I/O clock tree duty cycle distortion	All	0.14	0.14	0.14	0.14	ns
T_BUFIOSKEW	I/O clock tree skew across one clock region	All	0.03	0.03	0.03	0.03	ns
T_DCD_BUFR	Regional clock tree duty cycle distortion	All	0.18	0.18	0.18	0.18	ns

**Notes:**

- These parameters represent the worst-case duty cycle distortion observable at the I/O flip flops. For all I/O standards, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
- The T\_CKSKEW value represents the worst-case clock-tree skew observable between sequential I/O elements. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx FPGA\_Editor and Timing Analyzer tools to evaluate clock skew specific to your application.

## MMCM Switching Characteristics

Table 34: MMCM Specification

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
MMCM_F_INMAX	Maximum input clock frequency	800.00	800.00	800.00	800.00	MHz
MMCM_F_INMIN	Minimum input clock frequency	10.00	10.00	10.00	10.00	MHz
MMCM_F_INJITTER	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max				
MMCM_F_INDUTY	Allowable input duty cycle: 10—49 MHz	25	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	45	%
MMCM_F_MIN_PSCLK	Minimum dynamic phase-shift clock frequency	0.01	0.01	0.01	0.01	MHz
MMCM_F_MAX_PSCLK	Maximum dynamic phase-shift clock frequency	550.00	500.00	450.00	450.00	MHz
MMCM_F_VCOMIN	Minimum MMCM VCO frequency	600.00	600.00	600.00	600.00	MHz
MMCM_F_VCOMAX	Maximum MMCM VCO frequency	1600.00	1440.00	1200.00	1200.00	MHz

## PLL Switching Characteristics

Table 35: PLL Specification

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
PLL_F <sub>INMAX</sub>	Maximum input clock frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>INMIN</sub>	Minimum input clock frequency	19.00	19.00	19.00	19.00	MHz
PLL_F <sub>INJITTER</sub>	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max				
PLL_F <sub>INDUTY</sub>	Allowable input duty cycle: 19—49 MHz	25	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	45	%
PLL_F <sub>VCOMIN</sub>	Minimum PLL VCO frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>VCOMAX</sub>	Maximum PLL VCO frequency	2133.00	1866.00	1600.00	1600.00	MHz
PLL_F <sub>BANDWIDTH</sub>	Low PLL bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	1.00	MHz
	High PLL bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	4.00	MHz
PLL_T <sub>STATPHAOFFSET</sub>	Static phase offset of the PLL outputs <sup>(2)</sup>	0.12	0.12	0.12	0.12	ns
PLL_T <sub>OUTJITTER</sub>	PLL output jitter	Note 3				
PLL_T <sub>OUTDUTY</sub>	PLL output clock duty-cycle precision <sup>(4)</sup>	0.20	0.20	0.20	0.25	ns
PLL_T <sub>LOCKMAX</sub>	PLL maximum lock time	100.00	100.00	100.00	100.00	μs
PLL_F <sub>OUTMAX</sub>	PLL maximum output frequency	800.00	800.00	800.00	800.00	MHz
PLL_F <sub>OUTMIN</sub>	PLL minimum output frequency <sup>(5)</sup>	6.25	6.25	6.25	6.25	MHz
PLL_T <sub>EXTFDVAR</sub>	External clock feedback variation	< 20% of clock input period or 1 ns Max				
PLL_RST <sub>MINPULSE</sub>	Minimum reset pulse width	5.00	5.00	5.00	5.00	ns
PLL_F <sub>PFDMAX</sub>	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	450.00	MHz
PLL_F <sub>PFDMIN</sub>	Minimum frequency at the phase frequency detector	19.00	19.00	19.00	19.00	MHz
PLL_T <sub>FBDELAY</sub>	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle				

### Dynamic Reconfiguration Port (DRP) for PLL Before and After DCLK

T <sub>PLLDCK_DADDR</sub> /T <sub>PLLCKD_DADDR</sub>	Setup and hold of D address	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLDCK_DI</sub> /T <sub>PLLCKD_DI</sub>	Setup and hold of D input	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLDCK_DEN</sub> /T <sub>PLLCKD_DEN</sub>	Setup and hold of D enable	1.76/0.00	1.97/0.00	2.29/0.00	2.40/0.00	ns, Min
T <sub>PLLDCK_DWE</sub> /T <sub>PLLCKD_DWE</sub>	Setup and hold of D write enable	1.25/0.15	1.40/0.15	1.63/0.15	1.43/0.00	ns, Min
T <sub>PLLCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	0.99	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	100.00	MHz, Max

#### Notes:

1. The PLL does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any PLL outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as F<sub>VCO</sub>/128 assuming output duty cycle is 50%.

**Table 44: Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIO**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
Input Setup and Hold Time Relative to a Forwarded Clock Input Pin Using BUFIO for SSTL15 Standard.						
T <sub>PSCS</sub> /T <sub>PHCS</sub>	Setup and hold of I/O clock	-0.38/1.31	-0.38/1.46	-0.38/1.76	-0.16/1.89	ns

**Table 45: Sample Window**

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
T <sub>SAMP</sub>	Sampling error at receiver pins <sup>(1)</sup>	0.59	0.64	0.70	0.70	ns
T <sub>SAMP_BUFI0</sub>	Sampling error at receiver pins using BUFIO <sup>(2)</sup>	0.35	0.40	0.46	0.46	ns

**Notes:**

1. This parameter indicates the total sampling error of the Artix-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLKO MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
 These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of the Artix-7 FPGAs DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIO clock network and IDELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

**Additional Package Parameter Guidelines**

The parameters in this section provide the necessary values for calculating timing budgets for Artix-7 FPGA clock transmitter and receiver data-valid windows.

**Table 46: Package Skew**

Symbol	Description	Device	Package	Value	Units
T <sub>PKGSKEW</sub>	Package skew <sup>(1)</sup>	XC7A100T	CSG324	113	ps
			FTG256	120	ps
			FGG484	144	ps
			FGG676	153	ps
		XC7A200T	SBG484	111	ps
			FBG484	109	ps
			FBG676	121	ps
			FFG1156	151	ps

**Notes:**

1. These values represent the worst-case skew between any two SelectIO resources in the package: shortest delay to longest delay from die pad to ball.
2. Package delay information is available for these device/package combinations. This information can be used to deskew the package.

## GTP Transceiver Specifications

### GTP Transceiver DC Input and Output Levels

Table 47 summarizes the DC output specifications of the GTP transceivers in Artix-7 FPGAs. Consult [UG482: 7 Series FPGAs GTP Transceiver User Guide](#) for further details.

Table 47: GTP Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
$DV_{PPOUT}$	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	—	—	1000	mV
$V_{CMOUTDC}$	DC common mode output voltage	Equation based	$V_{MGTAVTT} - DV_{PPOUT}/4$			mV
$R_{OUT}$	Differential output resistance		—	100	—	$\Omega$
$V_{CMOUTAC}$	Common mode output voltage: AC coupled		$1/2 V_{MGTAVTT}$			mV
$T_{OSKEW}$	Transmitter output pair (TXP and TXN) intra-pair skew (FFG, FBG, SBG packages)		—	—	10	ps
	Transmitter output pair (TXP and TXN) intra-pair skew (FGG, FTG, CSG packages)		—	—	12	ps
$DV_{PPIN}$	Differential peak-to-peak input voltage	External AC coupled	150	—	2000	mV
$V_{IN}$	Absolute input voltage	DC coupled $V_{MGTAVTT} = 1.2V$	-200	—	$V_{MGTAVTT}$	mV
$V_{CMIN}$	Common mode input voltage	DC coupled $V_{MGTAVTT} = 1.2V$	—	$2/3 V_{MGTAVTT}$	—	mV
$R_{IN}$	Differential input resistance		—	100	—	$\Omega$
$C_{EXT}$	Recommended external AC coupling capacitor <sup>(2)</sup>		—	100	—	nF

#### Notes:

- The output swing and preemphasis levels are programmable using the attributes discussed in [UG482: 7 Series FPGAs GTP Transceiver User Guide](#) and can result in values lower than reported in this table.
- Other values can be used as appropriate to conform to specific protocols and standards.

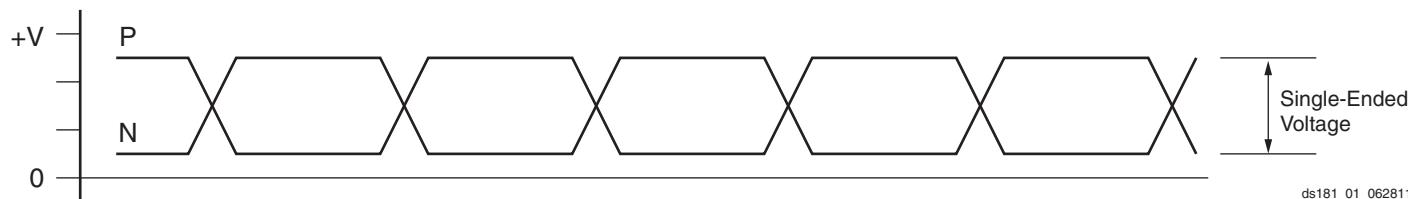


Figure 1: Single-Ended Peak-to-Peak Voltage

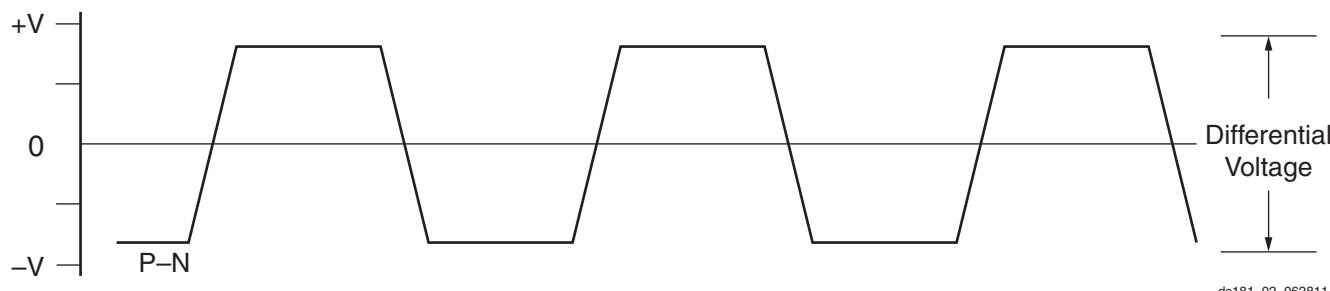


Figure 2: Differential Peak-to-Peak Voltage

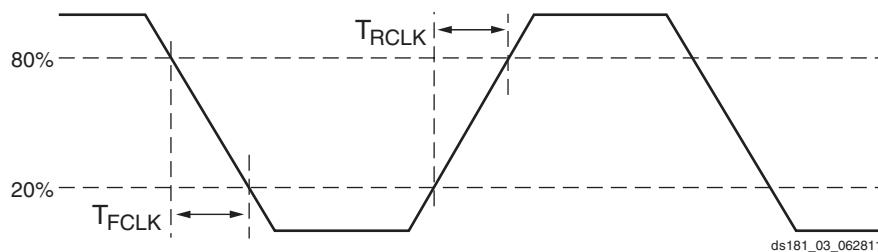


Figure 3: Reference Clock Timing Parameters

Table 52: GTP Transceiver PLL/Lock Time Adaptation

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
T <sub>LOCK</sub>	Initial PLL lock		—	—	1	ms
T <sub>DLOCK</sub>	Clock recovery phase acquisition and adaptation time.	After the PLL is locked to the reference clock, this is the time it takes to lock the clock data recovery (CDR) to the data present at the input.	—	50,000	2.3 x 10 <sup>6</sup>	UI

Table 53: GTP Transceiver User Clock Switching Characteristics<sup>(1)</sup>

Symbol	Description	Conditions	Speed Grade				Units
			1.0V			0.9V	
			-3	-2/-2L	-1	-2L	
F <sub>TXOUT</sub>	TXOUTCLK maximum frequency		412.500	412.500	234.375	234.375	MHz
F <sub>RXOUT</sub>	RXOUTCLK maximum frequency		412.500	412.500	234.375	234.375	MHz
F <sub>TXIN</sub>	TXUSRCLK maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz
F <sub>RXIN</sub>	RXUSRCLK maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz
F <sub>TXIN2</sub>	TXUSRCLK2 maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz
F <sub>RXIN2</sub>	RXUSRCLK2 maximum frequency	16-bit data path	412.500	412.500	234.375	234.375	MHz

**Notes:**

1. Clocking must be implemented as described in [UG482: 7 Series FPGAs GTP Transceiver User Guide](#).

## GTP Transceiver Protocol Jitter Characteristics

For Table 56 through Table 60, the [UG482: 7 Series FPGAs GTP Transceiver User Guide](#) contains recommended settings for optimal usage of protocol specific characteristics.

**Table 56: Gigabit Ethernet Protocol Characteristics**

Description	Line Rate (Mb/s)	Min	Max	Units
<b>Gigabit Ethernet Transmitter Jitter Generation</b>				
Total transmitter jitter (T_TJ)	1250	–	0.24	UI
<b>Gigabit Ethernet Receiver High Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	1250	0.749	–	UI

**Table 57: XAUI Protocol Characteristics**

Description	Line Rate (Mb/s)	Min	Max	Units
<b>XAUI Transmitter Jitter Generation</b>				
Total transmitter jitter (T_TJ)	3125	–	0.35	UI
<b>XAUI Receiver High Frequency Jitter Tolerance</b>				
Total receiver jitter tolerance	3125	0.65	–	UI

**Table 58: PCI Express Protocol Characteristics<sup>(1)</sup>**

Standard	Description	Line Rate (Mb/s)	Min	Max	Units
<b>PCI Express Transmitter Jitter Generation</b>					
PCI Express Gen 1	Total transmitter jitter	2500	–	0.25	UI
PCI Express Gen 2	Total transmitter jitter	5000	–	0.25	UI
<b>PCI Express Receiver High Frequency Jitter Tolerance</b>					
PCI Express Gen 1	Total receiver jitter tolerance	2500	0.65	–	UI
PCI Express Gen 2 <sup>(2)</sup>	Receiver inherent timing error	5000	0.40	–	UI
	Receiver inherent deterministic timing error		0.30	–	UI

**Notes:**

1. Tested per card electromechanical (CEM) methodology.
2. Using common REFCLK.

**Table 59: CEI-6G Protocol Characteristics**

Description	Line Rate (Mb/s)	Interface	Min	Max	Units
<b>CEI-6G Transmitter Jitter Generation</b>					
Total transmitter jitter <sup>(1)</sup>	4976–6375	CEI-6G-SR	–	0.3	UI
<b>CEI-6G Receiver High Frequency Jitter Tolerance</b>					
Total receiver jitter tolerance <sup>(1)</sup>	4976–6375	CEI-6G-SR	0.6	–	UI

**Notes:**

1. Tested at most commonly used line rate of 6250 Mb/s using 390.625 MHz reference clock.

Table 63: Configuration Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		1.0V		0.9V		
		-3	-2/-2L	-1	-2L	
<b>Internal Configuration Access Port</b>						
F <sub>ICAPCK</sub>	Internal configuration access port (ICAPE2) clock frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Master/Slave Serial Mode Programming Switching</b>						
T <sub>DCCCK/T<sub>CCKD</sub></sub>	DIN setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>CCO</sub>	DOUT clock to out	8.00	8.00	8.00	9.00	ns, Max
<b>SelectMAP Mode Programming Switching</b>						
T <sub>SMDCCK/T<sub>SMCCKD</sub></sub>	D[31:00] setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
T <sub>SMCSCCK/T<sub>SMCCKCS</sub></sub>	CSI_B setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	5.00/0.00	ns, Min
T <sub>SMWCCK/T<sub>SMCCKW</sub></sub>	RDWR_B setup/hold	10.00/0.00	10.00/0.00	10.00/0.00	12.00/0.00	ns, Min
T <sub>SMCKCSO</sub>	CSO_B clock to out (330 Ω pull-up resistor required)	7.00	7.00	7.00	8.00	ns, Max
T <sub>SMCO</sub>	D[31:00] clock to out in readback	8.00	8.00	8.00	10.00	ns, Max
F <sub>RBCCK</sub>	Readback frequency	100.00	100.00	100.00	70.00	MHz, Max
<b>Boundary-Scan Port Timing Specifications</b>						
T <sub>TAPTCK/T<sub>TCKTAP</sub></sub>	TMS and TDI setup/hold	3.00/2.00	3.00/2.00	3.00/2.00	3.00/2.00	ns, Min
T <sub>TCKTDO</sub>	TCK falling edge to TDO output	7.00	7.00	7.00	8.50	ns, Max
F <sub>TCK</sub>	TCK frequency	66.00	66.00	66.00	50.00	MHz, Max
<b>BPI Flash Master Mode Programming Switching</b>						
T <sub>BPICCO<sup>(2)</sup></sub>	A[28:00], RS[1:0], FCS_B, FOE_B, FWE_B, ADV_B clock to out	8.50	8.50	8.50	10.00	ns, Max
T <sub>BPIDCC/T<sub>BPICCD</sub></sub>	D[15:00] setup/hold	4.00/0.00	4.00/0.00	4.00/0.00	4.50/0.00	ns, Min
<b>SPI Flash Master Mode Programming Switching</b>						
T <sub>SPIDCC/T<sub>SPICCD</sub></sub>	D[03:00] setup/hold	3.00/0.00	3.00/0.00	3.00/0.00	3.00/0.00	ns, Min
T <sub>SPICCM</sub>	MOSI clock to out	8.00	8.00	8.00	9.00	ns, Max
T <sub>SPICCFC</sub>	FCS_B clock to out	8.00	8.00	8.00	9.00	ns, Max

**Notes:**

1. To support longer delays in configuration, use the design solutions described in [UG470: 7 Series FPGA Configuration User Guide](#).
2. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.

## eFUSE Programming Conditions

Table 64 lists the programming conditions specifically for eFUSE. For more information, see [UG470: 7 Series FPGA Configuration User Guide](#).

Table 64: eFUSE Programming Conditions<sup>(1)</sup>

Symbol	Description	Min	Typ	Max	Units
I <sub>FS</sub>	V <sub>CCAUX</sub> supply current	–	–	115	mA
t <sub>j</sub>	Temperature range	15	–	125	°C

**Notes:**

1. The FPGA must not be configured during eFUSE programming.

## Notice of Disclaimer

The information disclosed to you hereunder (the "Materials") is provided solely for the selection and use of Xilinx products. To the maximum extent permitted by applicable law: (1) Materials are made available "AS IS" and with all faults, Xilinx hereby DISCLAIMS ALL WARRANTIES AND CONDITIONS, EXPRESS, IMPLIED, OR STATUTORY, INCLUDING BUT NOT LIMITED TO WARRANTIES OF MERCHANTABILITY, NON-INFRINGEMENT, OR FITNESS FOR ANY PARTICULAR PURPOSE; and (2) Xilinx shall not be liable (whether in contract or tort, including negligence, or under any other theory of liability) for any loss or damage of any kind or nature related to, arising under, or in connection with, the Materials (including your use of the Materials), including for any direct, indirect, special, incidental, or consequential loss or damage (including loss of data, profits, goodwill, or any type of loss or damage suffered as a result of any action brought by a third party) even if such damage or loss was reasonably foreseeable or Xilinx had been advised of the possibility of the same. Xilinx assumes no obligation to correct any errors contained in the Materials, or to advise you of any corrections or update. You may not reproduce, modify, distribute, or publicly display the Materials without prior written consent. Certain products are subject to the terms and conditions of the Limited Warranties which can be viewed at <http://www.xilinx.com/warranty.htm>; IP cores may be subject to warranty and support terms contained in a license issued to you by Xilinx. Xilinx products are not designed or intended to be fail-safe or for use in any application requiring fail-safe performance; you assume sole risk and liability for use of Xilinx products in Critical Applications: <http://www.xilinx.com/warranty.htm#critapps>.

### AUTOMOTIVE APPLICATIONS DISCLAIMER

XILINX PRODUCTS ARE NOT DESIGNED OR INTENDED TO BE FAIL-SAFE, OR FOR USE IN ANY APPLICATION REQUIRING FAIL-SAFE PERFORMANCE, SUCH AS APPLICATIONS RELATED TO: (I) THE DEPLOYMENT OF AIRBAGS, (II) CONTROL OF A VEHICLE, UNLESS THERE IS A FAIL-SAFE OR REDUNDANCY FEATURE (WHICH DOES NOT INCLUDE USE OF SOFTWARE IN THE XILINX DEVICE TO IMPLEMENT THE REDUNDANCY) AND A WARNING SIGNAL UPON FAILURE TO THE OPERATOR, OR (III) USES THAT COULD LEAD TO DEATH OR PERSONAL INJURY. CUSTOMER ASSUMES THE SOLE RISK AND LIABILITY OF ANY USE OF XILINX PRODUCTS IN SUCH APPLICATIONS.